

# List of symbols

Note in advance: symbols that are used locally, i.e., within a subchapter only, are not included in the following list.

## Symbols

=	equal to
$\approx$	approximately equal to
$\sim$	very roughly equal to
$\propto$	proportional
$\equiv$	identical to
$\neq$	not equal to
$\alpha$	beam quality
$\alpha_p$	power absorption coefficient
$\beta$	angle of incidence
$\gamma$	ray angle
$\Gamma$	angular magnification
$\delta$	focal spot diameter (spot size of focus), or diameter of an image point
$\delta_B$	spot size of focus, or diameter of an image point when this is purely diffraction limited
$\delta_0$	spot size of focus, or diameter of an image point with respect to first dark strip or ring
$\delta_x, \delta_y$	width of an image point or spatial resolution in x- resp. y-direction
$\epsilon$	dielectric function or relative dielectric constant
$\epsilon_0$	dielectric permittivity of vacuum
$\eta_e$	external quantum efficiency (with respect to a single pixel)
$\eta_i$	internal quantum efficiency (with respect to a single pixel)
$\eta_g$	fill factor
$\theta$	angle of aperture or angle of diffraction
$\theta_0$	diffraction angle for first zero position
$\theta_{\max}$	diffraction angle corresponding to $k_{x,\max}$ or $k_{y,\max}$ ; $\sin(\theta_{\max}) = NA$
$\theta_t$	telecentricity value
$\kappa$	deformation coefficient, conic parameter
$\lambda$	wavelength of light
$\Lambda$	penetration depth
$\mu_0$	magnetic permeability of vacuum
$\nu$	frequency in general or frequency of the incident photon, in particular
$\nu_d, \nu_e$	Abbe numbers
$\Delta\nu_{\text{ampl}}$	amplifier bandwidth

$\Pi_G, \Pi_P$	Gaussian distribution, Poisson distribution
$\rho$	difference between the reciprocal curvature radii of a thin lens
$\rho_E$	amplitude reflection coefficient
$\rho_P$	power reflection factor, reflectance
$\sigma$	standard deviation
$\sigma_{\text{ampl}}$	noise of the (pre-)amplifier
$\sigma_{\text{dark}}$	dark signal noise (rms number of noise electrons)
$\sigma_{e,\text{tot}}$	total noise of a single pixel (rms number of noise electrons in total)
$\sigma_{pe}$	signal noise of the photoelectrons resulting from photon noise only
$\sigma_{ph}$	photon (or shot) noise
$\sigma_{\text{pix}}$	total noise of a single pixel (rms number in ADU; corresponds to $\sigma_{e,\text{tot}}$ )
$\sigma_{\text{read}}$	read noise
$\tau_E$	amplitude transmission coefficient
$\tau_f$	film transmittance
$\tau_P$	power transmission factor, transmittance
$\tau_{\text{read}}$	read (out) time
$\phi$	phase
$\Phi$	luminous resp. radiant power, flux
$\Phi_{\text{pix}}$	radiant flux or luminous flux of a pixel of the sensor
$\varphi$	angle
$\Delta\varphi$	angular resolution
$\Psi$	angle of view, angle of field
$\omega$	angular frequency
$\Omega, \Delta\Omega$	solid angle
$\mathbb{A}, \mathbb{B}, \mathbb{C}, \mathbb{D}$	elements of optical ray transfer matrix
$A, A_{\text{im}}$	area, area of image
$A_{\text{en}}, A_{\text{ex}}, A_{\text{eff}}$	area of entrance resp. exit pupil, effective area
$A_{\text{pix}}$	total area of a single pixel
$A'_{\text{pix}}$	photosensitive area of a single pixel
$a_2, a_4, a_6$	aspheric coefficients
$a_i, a_o$	image distance, object distance
$a_n, a_f, a_{hf}$	near point distance, far point distance, hyperfocal distance
$B_{\text{obj}}(x, y)$	brightness distribution within the object
$B_{\text{im}}(x, y)$	brightness distribution within the image
$\bar{B}(k_x, k_y)$	Fourier spectrum of $B(x, y)$
$B_{\text{pix}}$	brightness of an image point (i.e., a “pixel” within the image)
$B'_{\text{pix}}$	$B_{\text{pix}}$ after image processing; units are ADU or counts later on, a screen transfers $B'_{\text{pix}}$ , e.g., into radiant flux in W or radiant intensity in W/sr or something similar
$b_r$	brightness ratio
$c$	velocity of light in vacuum
$CF$	crop factor

$C_j$	junction capacitance of a photodiode
$C_L$	calibration constant for light meters
$C_o, C_i$	constants in object resp. image space
$C_{pix}$	capacity within a pixel
$d, d_{\text{sensor}}, d_{\text{FF}}$	diagonal of image format, of sensor, of full format
$d_{\text{ar}}$	thickness of antireflection layer
$D$	diameter
$D_{\text{eff}}$	effective usable diameter of the lens mount
$D_{\text{en}}, D_{\text{ex}}$	diameter of entrance pupil, diameter of exit pupil
$D_{\text{im}}$	diameter of image circle
$D_p$	pinhole diameter
$DR$	dynamic range
$dr$	depth resolution
$DS$	number of steps within the signal range
$DS_{\text{max}}$	maximum number of steps within the signal range
$\mathcal{E}$	electric field
$\mathcal{E}_{\text{obj}}(x, y)$	electric field distribution within the object plane
$\mathcal{E}_{\text{im}}(x, y)$	electric field distribution within the image plane
$e$	elementary charge
$e_{\text{Ho}}, e_{\text{Hi}}$	distance from reference plane $E$ to principal plane $H$
$E, E_v, E_e$	illuminance resp. irradiance
$E_{\text{il}}$	illuminance of incident light
$E_{\text{pix}}$	illuminance that is incident on a single pixel
$e_{\text{No}}, e_{\text{Ni}}$	distance from reference plane $E$ to nodal plane $N$
$EV$	exposure value
$F$	fluence (identical with radiant exposure)
$F_{\text{pix}}$	fluence that is incident on a single pixel
$\bar{F}_{\text{pix}}$	average $F_{\text{pix}}$ on the pixel
$FWC, N_{\text{full}}$	number of electrons that could be accumulated at maximum within a single pixel
$f(x)$	function in general
$f_{\#}$	f-number ( $= f/D$ )
$f_{\# \text{crit}}$	critical f-number
$f_{\text{Ei}}$	back focal length
$f_{\text{Eo}}$	front focal length
$f_{\text{norm}}, f_{\text{norm,FF}}$	focal length of normal lens
$f, f_o, f_i$	focal length, object resp. image focal length
$G$	gain
$G_a$	amplifier gain
$G_c$	conversion gain
$G_i$	input referred conversion gain
$G_{\text{out}}$	output referred conversion gain

$h$	Planck's constant
$h$	ray elevation from optical axis, off-axis image distance
$H_{\text{av}}, H_{\text{m}}$	recommended average exposure, film exposure at threshold
$h_{\text{i}}$	image height
$H, H_{\text{v}}, H_{\text{e}}$	luminous resp. radiant exposure
$H_{\text{pix}}$	luminous exposure that is incident on a single pixel
$I$	intensity
$I_{\text{pe}}$	photo current of one pixel
$I_{\text{dark}}$	dark current
$I_{\text{pix}}$	intensity that is incident on a single pixel (prior to losses)
$I'_{\text{pix}}$	intensity that is incident on a single pixel after loss-correction, i.e., intensity on the photo diode surface
$\bar{I}_{\text{pix}}$	average $I_{\text{pix}}$ on the pixel
$j_{\text{pe}}$	photo current density of one pixel
$J_{\text{v}}, J_{\text{e}}$	luminous resp. radiant intensity
$\vec{k}$	wave vector
$k$	absolute value of the wave vector
$k_{\text{cutoff}}$	cut-off frequency
$k_x, k_y, k_z$	spatial frequencies
$k_{x,\text{max}}, k_{y,\text{max}}, k_{\text{max}}$	maximum possible spatial frequency for a given optical system in x- or y-direction, respectively, or in general
$k_{\text{B}}$	Boltzman's constant
$K_{\text{m}}, K'_{\text{m}}$	luminous efficacy
$l$	length
$l_{\text{eff}}$	effective available distance in camera body
$l_{\text{opt}}$	optical path length
$l_{\text{ot}}$	optical tube length
$L, L_{\text{v}}, L_{\text{e}}$	luminance resp. radiance
$m$	integer number
$\mathbf{M}_{\text{L}}, \mathbf{M}_{\text{os}}$	lens matrix, ray transfer matrix of the optical system
$m_{\text{o}}, m_{\text{i}}$	slope in object resp. image space
$M_{\text{p}}$	pupil magnification
$M, M_{\text{v}}, M_{\text{e}}, M_{\text{rel}}, M_{\text{rel,FF}}$	magnification
$n, n_{\text{o}}, n_{\text{i}}, n_0, n_1, n_2, n_{\text{s}}, n_{\text{ar}}$	refractive index
$NA, NA_{\text{o}}, NA_{\text{i}}$	numerical aperture, in object respectively image space
$N_{\text{e}}$	number of electrons generated within one pixel (this includes, e.g., $N_{\text{pe}}$ and $N_{\text{dark}}$ )
$N_{\text{e,min}}$	minimum value of $N_{\text{pe}}$
$N_{\text{e,max}}$	maximum value of $N_{\text{pe}}$

$\Delta N_e$	uncertainty of the number of electrons generated within one pixel (usually rms value; due to noise)
$N_{\text{eff}}$	effective value of number of read out electrons
$N_h$	number of pixels in horizontal direction, e.g., of a screen or sensor
$N_v$	number of pixels in vertical direction, e.g., of a screen or sensor
$N_{\text{period}}$	number of pixels within one period of a test grating (for a PDA)
$N_{\text{pe}}$	number of photo-generated electrons within one pixel
$N_{\text{ph}}$	number of photons illuminating one pixel (prior to losses)
$N_{\text{ph,th}}$	minimum number of photons that are necessary to provide a signal beyond read noise background (prior to losses)
$N_{\text{ph,sat}}$	maximum number of photons that could be collected within one pixel to get FWC (prior to losses)
$N_{\text{ph,18}}$	number of photons (prior to losses) to achieve $18\% \cdot N_{\text{full}}$
$N'_{\text{ph}}$	number of photons incident to one pixel (after loss-correction)
$N_{\text{dark}}$	number of charges contributing to dark current within one pixel
$N_{\text{read}}$	number of charges due to read noise within one pixel (rms value)
$N_{\text{reset}}$	number of charges due to reset noise within one pixel (rms value)
$N_{\text{SB}}$	value of the space bandwidth number SBN
$N_{\text{full}}$	number of electrons that could be accumulated at maximum within a single pixel
$OD, OD_{\text{min}}, OD_{\text{max}}$	optical density
$p$	pixel size
$P$	power
$P_o, P_i$	points in object resp. image space
$q$	(single) charge
$q_{\text{pix}}$	signal charge per pixel
$q_{\text{ph}}$	charge generated per photon
$q_{\text{full}}$	saturation value of $q_{\text{pix}}$
$Q, Q_v, Q_e$	luminous resp. radiant energy
$\mathcal{R}$	resolution
$r$	radius, radius of spherical lens
$R$	$1/\lambda$ (corresponds to $k = 2\pi/\lambda$ )
$R_{\text{cutoff}}$	cut-off frequency
$R_{\text{out}}$	resistance; the output voltage is measured at that resistor
$R_{\text{pix}}$	responsivity
$R_{\text{MTF0}}$	spatial frequency, where the MTF becomes zero
$R_{\text{MTF10}}$	spatial frequency, where the MTF becomes 10%
$R_{\text{MTF50}}$	spatial frequency, where the MTF becomes 50%

$R_N$	Nyquist frequency
$R_S$	sampling frequency
$R_x, R_y, R_z$	spatial frequencies (sometimes space-frequencies)
$R_\varphi$	spatial frequency with respect to the observation angle of the eye
$R_{x,\max}, R_{y,\max}$	maximum possible spatial frequencies for a given optical system
$S$	signal in general
$S_{\text{pix}}$	signal generated within a single pixel in ADU
$S, S_{\text{ISO}}, S_{\text{DIN}}^\circ$	sensor speed, sensitivity
$s_{\text{DOF}}, s_{\text{DOFoc}}$	depth of field, depth of focus
$s_i, s_o$	magnitude of object resp. image distance
$S_i, S_o$	image resp. object size
$T$	transmission, or sometimes absolute temperature
$T_F$	transmission function, which describes losses of light before it is incident on the photosensitive region of the photodiode
$T_{\text{film}}$	film transmission
$t$	time
$t_L$	lens thickness
$t_s$	lens separation
$t_x$	exposure time resp. shutter speed
$U_{\text{bi}}$	photodiode built-in voltage due to diffusion
$U_d$	photodiode voltage
$u_o, u_i$	diameter of circle of confusion in object and image space
$u_p, u_d$	diameter of projection blur, diffraction blur
$U$	voltage (in general)
$U_{\max}$	maximum voltage at the photodiode
$U_{\text{out}}$	output voltage per pixel
$U_{\text{eff}}$	effective value of a voltage (rms value)
$U_{\text{read}}$	effective value of read out voltage noise (rms value)
$U_{\text{reset}}$	reset voltage
$U_r$	photodiode reverse bias voltage
$V, V_i$	refractive power
$v_{\text{Ho}}, v_{\text{Hi}}, v_{\text{No}}, v_{\text{Ni}}$	distance from vertices to cardinal points in a thick lens
$V_{\text{ph}}(\lambda), V'_{\text{ph}}(\lambda)$	photopic resp. scotopic standard luminosity function
$W$	energy in general
$W_{\text{ph}}$	photon energy
$W_{\text{pix}}$	(radian) energy that is incident on a single pixel
$W'_{\text{pix}}$	energy that is incident on a single pixel (after loss-correction)
$W_g, W_{\text{ph}}$	band gap energy, photon energy
$WF_r(x, y), WF_i(x, y)$	real wave front, resp. ideal wave front
$\Delta WF(x, y)$	wave front aberration
$X, Y$	image width, height
$X_o, Y_o$	width resp. height of an object (size in x- resp. y-direction)

$x, y, z$	space coordinates
$x_o, x_i$	$x$ -coordinate, in the object plane resp. image plane
$x_0$	position of the first zero point int the image plane: distance from the optical axis
$X_{e,\lambda}, X_{v,\lambda}$	radiometric resp. photometric quantity
$z_a$	astigmatic difference
$z_s$	longitudinal spherical aberration

### Abbreviations

1D	one dimension
2D	two dimension
ADC	analogue-to-digital (A/D) converter
ADU	analogue digital unit; this is equal to DN (digital numbers), DV (digital values) or counts, respectively
APS	active pixel sensor
APS-C	film-/sensorformat
AR	anti reflection
BSI	back side illumination
c. c.	complex conjugate
CCD	charge coupled device
CDS	correlated double sampling method
CF	crop factor
CFA	color filter array
CIS	CMOS Image Sensor
CMOS	complementary metal oxide semiconductor
CSF	contrast sensitivity function
DN	digital number; same as ADU
DNG	digital negative
DU	digital unit; same as ADU
DOF	depth of field
DR	dynamic range
DRI	dynamic range increase
DS	number of data steps or depth steps
DSC	digital still camera (in contrast to, e.g., a video camera)
DSLR	digital single lens reflex camera
DSLM	digital single lens mirrorless camera
DSNU	dark signal non-uniformity
EBI	equivalent background illumination
epi layer	epitaxial layer
ESF	edge spread function
EUV	extreme ultraviolet

EV	exposure value (= aperture stop, f-stop)
FF	fill factor
FFC	flat field correction
FO	fibre optics
FPN	fixed pattern noise
FT	Fourier transformation
FWC	full well capacity
FWHM	measured at full width at half maximum
HDR	high dynamic range
HV	high voltage
IC	integrated (electronic) circuit
ICCD	intensified CCD
iFT	inverse Fourier transformation
IR	infrared
LDR	low dynamic range
lp	line pair
lp/PH	number of line pairs within the picture height
l/PH	number of lines within the picture height
LCD	liquid crystal display
LSF	line spread function (LSF = $\int_y \text{PSF}(y)dy$ )
MCP	micro channel plate
MOS	metal oxide semiconductor
MOSFET	metal oxide field effect transistor
MP	mega pixel (unit used for cameras)
MTF	modulation transfer function
MTF	modulation transfer function for the field
NA	numerical aperture
NIR	near infrared
OD	optical density
OECF	opto-electronic conversion function
OMA	optical micro lens array
OLPF	optical low pass filter
PC	personal computer
PDA	photo diode array (this may be 1D or 2D; in a more general sense, also CCD or CMOS may be regarded as PDA)
pixel	picture element
PH	picture height (or height of an image or sensor)
PW	picture width (or width of an image or sensor)
PRNU	photo response uniformity
PTF	phase transfer function
OPD	optical path difference

OTF	optical transfer function
$\mathcal{OTF}$	coherent transfer function sometimes termed as amplitude transfer function (for the field)
PSF	point spread function
$\mathcal{PSF}$	point spread function for the field (coherent point spread function)
PTC	photon transfer curve
QE	quantum efficiency
EQE	external quantum efficiency (or overall quantum efficiency)
IQE	internal quantum efficiency
RGB	red green blue
RMS, rms	root mean square
ROI	region of interest
SBN	space bandwidth number (term is used for both, one or two dimensions)
SBP	space bandwidth product
sCMOS	scientific CMOS
SFR	spatial frequency response
SLR	single lens reflex camera
SLT	single lens translucent
SQF	subjective quality factor
SNR	signal-to-noise-ratio
TBP	time bandwidth product
TSV	through-silicon <i>via</i>
TTL	through the lens
UV	ultraviolet
vis	visible light range
VN	visual noise
WF	wave front
WFA	wave front aberration
XR	X-ray
XUV	extreme ultraviolet